

Notice of References Cited	Application/Control No. 10/596,777		Applicant(s)/Patent Under Reexamination DE VRIES, MARTIN	
	Examiner ISAAK R. JAMA		Art Unit 2617	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,146,167	12-2006	Tanabe, Yoichi	455/436
*	B	US-6,892,071	05-2005	Park et al.	455/436
*	C	US-7,020,108	03-2006	Virtanen, Anu	370/331
*	D	US-6,810,019	10-2004	Steudle, Ville	370/252
*	E	US-7,190,944	03-2007	Kim et al.	455/346
*	F	US-6,868,075	03-2005	Narvinger et al.	370/335
*	G	US-7,376,424	05-2008	Kim et al.	455/436
*	H	US-2003/0108027	06-2003	Kim et al.	370/345
*	I	US-2004/0156324	08-2004	Steudle, Ville	370/278
*	J	US-2004/0009767	01-2004	Lee et al.	455/422.1
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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